

Supporting Information

Coupling an Organic Photosensitizer and Inorganic Framework into a Single-Phase Material that Shows Visible-Light Photocurrent Response

Tao Zhang,^{†,a,b} Yue-Qiao Hu,^{†,a,c} Qian-Wen Li,^a Wei-Peng Chen^a and Yan-Zhen Zheng^{*,a}

^a *Xi'an Jiaotong University Shenzhen Research School, Frontier Institute of Science and Technology (FIST), State Key Laboratory for Mechanical Behavior of Materials, MOE Key Laboratory for Nonequilibrium Synthesis of Condensed Matter, Xi'an Key Laboratory of Sustainable Energy and Materials Chemistry and School of Chemistry, Xi'an Jiaotong University, 99 Yanxiang Road, Xi'an, Shaanxi 710054, P. R. China.*

^b *Key Laboratory of Special Functional and Smart Polymer Materials of Ministry of Industry and Information Technology, School of Chemistry and Chemical Engineering, Northwestern Polytechnical University, Xi'an, Shaanxi. 710129, China.*

^c *Key Laboratory of Advanced Molecular Engineering Materials, College of Chemistry and Chemical Engineering, Baoji University of Arts and Sciences, Baoji 721013, China.*

[†] *These authors contributed equally.*

Table of Contents

Supporting Information	1
1. Experimental Section.....	3
2. X-Ray Crystallography Structure and Data	4
3. Theoretical calculation	5
4. Photograph of single-crystal sample of 1	5
5. FT-IR	6
6. TG	6
7. CV curve.....	7
8. Reference	7

1. Experimental Section

General Consideration.

All chemicals were commercially available and were used as received. All solvents were used without any further treatments. All manipulations were performed in air. Powder X-ray diffractometry spectroscopy (PXRD) data were collected on a Rigaku Smartlab X-ray diffractometer with CuK α radiation ($\lambda = 1.5418 \text{ \AA}$). Infrared spectra were collected on a Thermo Fisher Nicolet 6700 FT-IR spectrometer using ATR (Attenuated Total Reflectance) method. Cyclic voltammetry (CV) and Mott-Schottky measurements were performed using AutoLab PGSTAT302N equipment. The diffuse reflection spectrum of **1** was measured by UV-vis-NIR spectrophotometer PE Lambda950 at Instrument Analysis Center of Xi'an Jiaotong University.

Single crystal X-ray diffraction.

Crystal data was collected on a Bruker Apex CCD area-detector diffractometer using MoK α ($\lambda = 0.71073 \text{ \AA}$) radiation. The structures were solved using direct methods and refined with a full-matrix least-squares technique using OLEX2 program package.¹ Anisotropic thermal parameters were assigned to all non-hydrogen atoms. The hydrogen atoms were generated geometrically. CCDC-1843769 contains the supplementary crystallographic data for this paper. These data can be obtained free of charge via www.ccdc.cam.ac.uk/data_request/cif.

Synthesis of [Ru(bpy)₃](PF₆)₂. The two-step synthesis procedure is according to a reported method.²

Firstly, preparation of *cis*-Ru(bpy)₂Cl₂·2H₂O: RuCl₃·3H₂O (3.9 g, 15 mmol), 2,2'-Bipyridine (4.7 g, 30 mmol), and LiCl (4.2 g, 100 mmol) were added to 100 mL DMF, affording a dark slurry. The mixture was heated at 170 °C and refluxed for 8 hours. After cooling down to room temperature, 250 mL acetone was added and the solution was stored at 0 °C overnight, which gave dark green product. The solid was washed with water and diethyl ether and dried in air, yields 63 % based on Ru.

Finally, synthesis of [Ru(bpy)₃](PF₆)₂: under argon atmosphere, *cis*-Ru(bpy)₂Cl₂·2H₂O (3.0 g, 5.8 mmol), 2,2'-Bipyridine (1.5 g, 10 mmol) were added to the 100 mL degassed mixture of H₂O/EtOH (1:1 in v/v), generating a dark suspension. Then the mixture was heated at 130 °C for 6 hours, the suspension became clear solution and a color change from dark green to wine red was observed. Subsequently, the solution was concentrated and NH₄PF₆ (3.3 g, 20 mmol) was added, which afforded light orange precipitate as product. The solid was filtrated and washed with water and diethyl ether, dried in air (*ca.* 50 % based on Ru).

Synthesis of **1**.

In a 15 mL Teflon-lined stainless steel reactor, slurry of tin (100 mg, 1.6 mmol), selenium (200 mg, 2.5 mmol), [Ru(bpy)₃](PF₆)₂ (0.5 mmol), glycol (3 mL), water (3 mL) and en (1 mL) was heated at 190 °C for 14 days, and then cooled down to room temperature in 48 h. Dark red crystals of **1** were washed with DMF and dried in vacuum (Yield: *ca.* 60 % based on Sn).

Two-point probe conductivity measurements.

The powder sample of **1** was pressed into pellet with diameter 1.3 cm and thickness 0.11 cm, which was painted with silver paste and further connected to a combination of a picoameter (Keithley 6485) and a source meter (Keithley 2400) with platinum wires. Current-voltage (I - V) were scanned at various voltage ranges according to the resistance of the samples and the sensitivity of the instrument. The conductivity was obtained by the Ohm's law. The photocurrent measurement was performed under irradiation of Xe lamp with power of 350 W.

Optical absorption measurement.

Solid-state UV-Vis diffuse reflectance spectra were measured on a PE Lambda950 UV-Vis-NIR spectrophotometer using BaSO₄ powder as the reflectance reference. The absorption spectra were calculated from reflectance spectra by the Kubelka-Munk function: $F(R) = \alpha/S = (1-R)^2/2R$, where R , α , and S are the coefficients for the reflection, the absorption and the scattering, respectively.

Cyclic voltammetry (CV) measurement.

A three-electrode system was used to investigate the electrochemical property of **1**. The reference electrode was Ag/AgCl in saturated KCl, and the counter electrode was platinum wire. The powder sample of **1** (5 mg), acetylene black (5 mg) were dispersed in the mixture of 1 mL of CH₃CH₂OH and 50 μ L Nafion and subsequently loaded on the glassy carbon and dried under the infrared light source, which was used as the working electrode. The CV measurement was conducted in 0.1 M NBu₄PF₆ in degassed CH₃CN with scan rate 100 mV/s.

Mott-Schottky measurement.

Powder sample of **1** (5 mg) together with acetylene black (5 mg) were dispersed in the mixture of 1 mL of CH₃CH₂OH and 50 μ L Nafion and subsequently loaded on the glassy carbon and dried under the infrared light source, which was used as the working electrode. Pt worked wire as counter electrode and Ag/AgCl worked as reference electrode. The measurements were conducted 0.1 M NBu₄PF₆ in degassed CH₃CN. The working frequencies were 1, 10, 100, and 1000 Hz from 0 to 2.0 V.

2. X-Ray Crystallography Structure and Data

Table S1. Crystal data and structure refinement for **1**.

1	
formula	C ₃₀ H ₂₄ N ₆ RuSe ₉ Sn ₄
$M/g\ mol^{-1}$	1755.02
crystal system	trigonal
space group	$R\bar{3}c$
$a, \text{\AA}$	27.2403(10)
$b, \text{\AA}$	27.2403(10)
$c, \text{\AA}$	31.010(2)
$V, \text{\AA}^3$	19927(2)
Z	18

$d_{cal}/\text{g cm}^{-3}$	2.632
temperature, K	296.15
2θ range	4.338 to 49.626
completeness	0.96
residual map, e \AA^{-3}	2.22/-1.27
Goodness-of-fit on	1.031
final indices	$R_1 = 0.0293$, $wR_2 = 0.0711$
R indices (all data)	$R_1 = 0.0317$, $wR_2 = 0.0726$
Flack parameter	0.742(11)

[a] $GOF = [\sum w(F_o^2 - F_c^2)^2 / (n_{obs} - n_{param})]^{1/2}$.

[b] $R_1 = \frac{||F_o| - |F_c||}{\sum |F_o|}$, $wR_2 = [\sum w(F_o^2 - F_c^2)^2 / \sum w(F_o^2)]^{1/2}$.

3. Theoretical calculation

The DFT calculation was carried out using CASTEP module⁴ in Material Studio software package. The structure information was taken from the data from single-crystal diffraction. Considering the large unit cell and number of atoms, the conventional cell was transformed into a primitive cell for calculation. The general gradient approximation (GGA) in PBE form³ was used during the calculation and the SCF tolerance was set to be 10^{-6} Ha. The TS method⁵ was applied for van der Waals dispersion correction. The plane wave basis set was used in the calculation. The $1 \times 1 \times 1$ Monkhorst-Pack k -point grids⁶ were used to sample the Brillouin zone for the material.

4. Photograph of single-crystal sample of 1

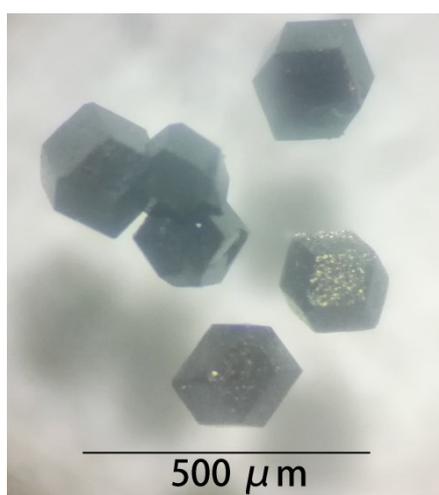


Figure S1. Photograph of single-crystal sample of 1.

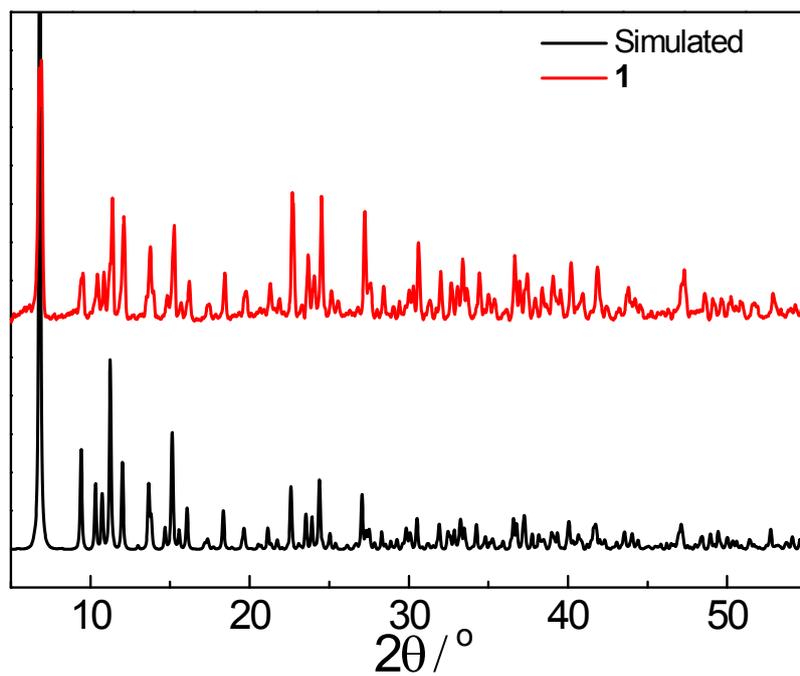


Figure S2. PXRD pattern of powder sample of 1.

5. FT-IR

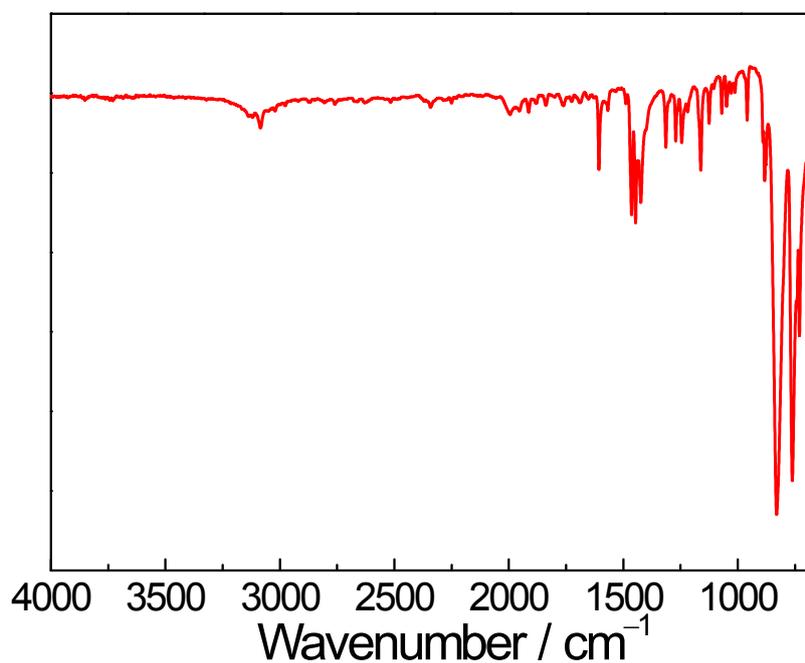


Figure S3. FT-IR of 1.

6. TG

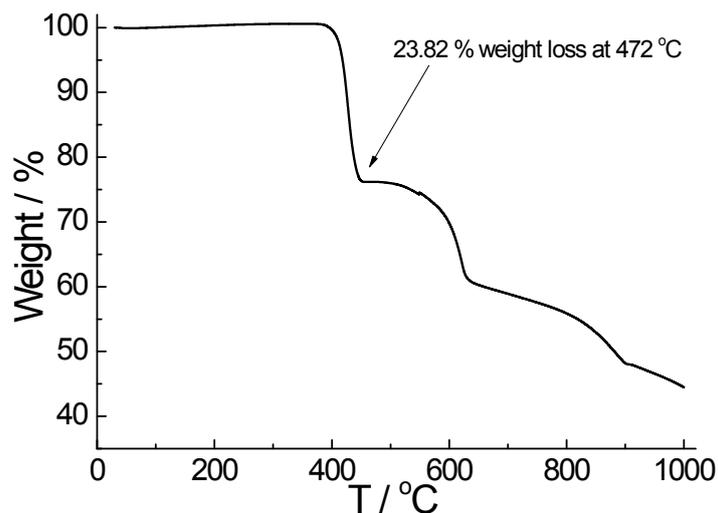


Figure S4. TG curve of **1**

7. CV curve

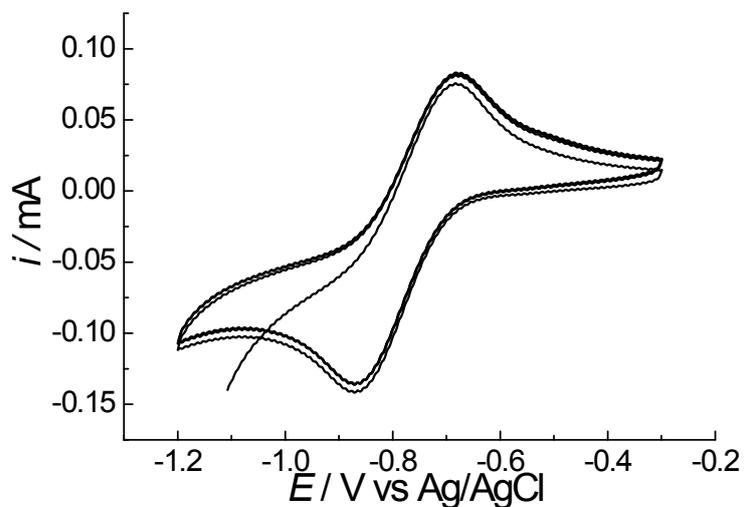


Figure S5 . CV curve of **1**

8. Reference

- (1) Dolomanov, O. V.; Bourhis, L. J.; Gildea, R. J.; Howard, J. A. K.; Puschmann, H. *J. Appl. Cryst.* 2009, **42**, 339–341.
- (2) B.P. Sullivan, D. J. Salmon, and T. J. Meyer. *Inorg. Chem.* 1978, **17**, 3334–3341.
- (3) J. P. Perdew, K. Burke, M. Ernzerhof, *Phys. Rev. Lett.* **1996**, *77*, 3865–3868.

- (4) S. Clark, M. D. Segall, C. J. Pickard, P. J. Hasnip, M. I. J., Probert, K. Refson, M. C. Payne, *Z. Kristallogr.* **2005**, 220, 567–570.
- (5) A. Tkatchenko, M. Scheffler, *Phys. Rev. Lett.* **2009**, 102, 73005.
- (6) H. J. Monkhorst, J. D. Pack, *Phys. Rev. B* **1976**, 13, 5188–5192.